# Irreversibility line in YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub> thin films: Correlation of transport and magnetic behavior

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Using magnetic and magnetotransport measurements, we show that a YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub> thin-film sample has a single irreversibility line (IRL), which is the same as the vortex-glass-transition phase boundary. Results suggest that the effects of pinning persist above the glass-transition temperature  $T_g$ , and that it is the loss of critical-current density  $J_c$  rather than an onset of reversible magnetic behavior that characterizes the vortex-glass transition. Measurements of dc magnetization are shown to confirm a theoretical model that explains why the determination of  $T_g$  requires that field-cooled data be collected on cooling (FCC) rather than on warming (FCW), as is frequently done. The use of the ac susceptibility response for measuring  $T_g$  is shown to be a valid measure only at low frequency. This is because both the fundamental-frequency and third-harmonic ac susceptibilities measure the onset of ac flux penetration rather than the onset of irreversibility. The frequency dependence of the onset temperature of ac flux penetration ( $T_{on}$ ) is shown to follow the vortex-glass-model dependence  $T_{on} = C(2\pi f)^{[1/[(z-1)\nu]]} + T_g$ , with values of z and v consistent with those determined from scaling of the magnetotransport data.

### I. INTRODUCTION

The first observation of the so-called "irreversibility line" (IRL) in high-temperature superconductors was that of Müller, Tagashige, and Bednorz on a polycrystalline sample of  $(La_{2-x}Ba_x)CuO_4$ .<sup>1</sup> They used a dc magnetic method that has become one of the standard methods for measuring the IRL. The IRL they determined was a curve with a dependence  $B \sim (1-t)^{3/2}$ , where the reduced temperature  $t = T/T_c$ . Since this dependence was the same as that characterizing spinglass transitions, the transition was by analogy referred to as a vortex-glass transition. Various models were put forward to describe this crossing from irreversible to apparently reversible magnetic behavior. The first of these models treated the ceramic superconductor as an agglomeration of separate superconducting grains connected by a grain-boundary phase, which results in superconducting weak links between grains.<sup>2,3</sup>

Other competing explanations<sup>4,5</sup> for the IRL were later presented, including a model based on flux creep.<sup>6</sup> When the properties that had been attributed to the polycrystalline nature of the materials also were observed in single crystals, the flux-creep interpretation of the IRL found favor. In the flux-creep model, the IRL is not a thermodynamic phase transition, but rather a dynamic crossover resulting from the crossing from a regime in which the system response is flux-flow dominated to one that is pinning dominated. Further apparent support for this model came from the time dependence of the magnetization,<sup>7</sup> the frequency dependence of the IRL when measured by ac susceptibility ( $\chi_{ac}$ ),<sup>8</sup> and the Arrhenius dependence of the resistivity.<sup>9</sup> The flux-creep model also predicts that a linear resistivity exists in the limit of zero current density.

The early measurements of voltage as a function of current (V-I) on thin films of  $YBa_2Cu_3O_{7-\delta}$  (YBCO) showed a behavior that could be described by the fluxcreep model.<sup>10</sup> This study also showed that the pinning potential energy U had a current density (J) dependence described by  $U \propto \ln(J_c/J)$ , where  $J_c$  is the critical-current density. This dependence has been confirmed by more re-cent magnetic measurements.<sup>11</sup> Other models that could account for this U(J) dependence were put forward, including the collective-flux-creep model of Feigel'man et al.<sup>5</sup> In addition to U(J), their theory was able to account for long- and short-term relaxation results<sup>12</sup> and the temperature dependence of the critical-current densi-ty  $(J_c)$ .<sup>13,14</sup> More recent V-I measurements have shown that the positive-curvature flux-creep-type V-I behavior observed earlier<sup>10</sup> can give way at lower temperatures to a region of negative curvature.<sup>15</sup> Associated with this negative curvature is a disappearance of the linear resistivity resulting from the divergence of U in the small-Jlimit. The models that predict this crossover in V-Ibehavior are the model of Feigel'man et al. and the vortex-glass model of Fisher, Fisher, and Huse.<sup>4</sup> Their models, like other models describing a transition of the vortex lattice into a glassy state, consider the IRL to be a thermodynamic phase transition rather than a dynamic crossover. The confirmed disappearance of the linear resistivity greatly improves the prospects for application of these superconductors.

Several methods have been used to measure the IRL, and as a result, several definitions for the IRL have emerged. It is our contention that for the case of YBCO thin films of sufficient thickness, there is only one IRL and it is the same as  $T_g$  measured by transport. Here we present results of various IRL measurement methods. The first measurement of the IRL, by Müller, Tagashige, and Bednorz using dc magnetization measurements, seemed to provide a reliable method.<sup>1</sup> However, we will show that a commonly used variation of this method does not provide reliable results. The use of fundamentalfrequency ac susceptibility  $(\chi_1)$  became a popular method to measure the IRL, even after the warnings of Shaulov and Dorman.<sup>16</sup> More recently, the realization that  $\chi_1$  is a measure of ac flux penetration $^{17-19}$  rather than irreversibility has led many to choose the third-harmonic ac susceptibility response to determine the IRL. The basis for using this method is that the existence of irreversibility will produce harmonics.<sup>20</sup> However, we will show that there is actually a coincidence of both the fundamental and third-harmonic response onsets which results from ac flux penetration occurring in a region in which the current-voltage behavior is nonlinear.

#### **II. EXPERIMENTAL DETAILS**

Epitaxial YBCO thin films, with the c axis perpendicular to the film plane, were prepared by pulsed laser deposition onto heated (001) LaAlO<sub>3</sub> substrates using a method described previously.<sup>21</sup> The superconducting transition temperatures  $(T_c)$  ranged from 89.8 to 90.3 K, and the transition width  $\Delta T_c$  was about 2 K as measured by ac susceptibility at 2.5 MHz. Measurements of the voltage as a function of current (V-I), ac susceptibility  $(\chi_{ac})$ , and dc magnetization as a function of temperature were made on the same thin-film sample using procedures described previously.<sup>22</sup> The  $\chi_{ac}$  measurements include the in- and out-of-phase responses at the fundamental and the third-harmonic frequencies. Three different types of dc magnetization measurements were made. These included zero-field cooled (ZFC) "field cooled with data collected on warming" (FCW), and "field cooled with data collected on cooling" (FCC).

# **III. RESULTS AND DISCUSSION**

### A. Transport

Figure 1 is a plot of electric field E versus current density J for a 3000-Å-thick film in an applied magnetic field H = 30 kOe. Similar data sets were collected at various values of H. The electric field is determined using the relation E = V/L, where V is the measured voltage and L is the length of the film bridge. The current density is



FIG. 1. Plots of  $\ln E$  vs  $\ln J$  for a 3000-Å YBCO thin film in an applied magnetic field H=30 kOe. Each curve is an isotherm, ranging from 70 K at the lower right to 89 K at the upper left, in increments of 1 K. The dot-dashed line at higher temperatures identifies the isotherm  $E(J, T=T_{Ohm}=84.8 \text{ K})$ , while the dashed line is the glass transition isotherm,  $E(J, T=T_g=77.8 \text{ K})$  determined from scaling the E-J results.

determined using the relation J = I/A, where A is the cross-sectional area of the film bridge. The E-J curves are isotherms, ranging in 1-K increments from 70 K at the lower right to 89 K at the upper left. Three regions of differing curvature can be distinguished. At the highest temperatures, an Ohmic region is evident. As the temperature is decreased, a positive-curvature region develops, with individual isotherms in this region showing a crossing from Ohmic to power-law behavior as the current increases. The temperature of crossing from Ohmicbehavior isotherms to positive-curvature isotherms is denoted as  $T_{Ohm}$  (dot-dashed line). As the temperature is decreased further, the E-J curvature becomes negative. The temperature of crossing from positive to negative-curvature isotherms is denoted T<sub>g</sub> (dashed line).

Values of  $T_{Ohm}$  at various applied fields are plotted in Fig. 2. These values fall below the  $H_{c2}$  curve  $(T_{c2})$  that was estimated using the measured transition temperature (at H=0) for the film in combination with prior determinations of  $H_{c2}$  on YBCO crystals.<sup>23</sup> As a result of experimental limits on J and E,  $T_{Ohm}$  is defined as the lowest temperature for which an E-J isotherm is Ohmic to the highest observed current density. The resistivity of the  $T_{Ohm}$  isotherms was found to be roughly 50  $\mu\Omega$  cm at all fields. It is observed that the Ohmic region above  $T_{Ohm}$  curve in Fig. 2 has completely reversible dc magnetic behavior. The transport behavior in this region of the E-J curves is due to thermally enhanced flux flow.

Below  $T_{Ohm}$  and above  $T_g$ , the *E-J* behavior (Fig. 1) is characteristic of thermally activated flux motion and manifests a crossing from Ohmic behavior at small *J* to power-law behavior at larger *J* values, with a nonzero linear resistance at all *J*. Recent results support the idea that thermal fluctuations enhance flux flow also in this region of *E-J* behavior.<sup>24</sup> Even though there is a linear component in the *E-J* behavior of this regime, it is not necessary that the M(H) behavior be reversible, except in the small *E-J* limit, where the *E-J* behavior is Ohmic. Measurements on a sufficiently long time scale do show 90



80

T (K)

85

evidence of reversible behavior resulting from the resistive decay of J into the Ohmic portion of the E-J curve. On the other hand, in the case of single crystals the crossing from purely Ohmic to purely power-law behavior has been used to define the IRL.<sup>25</sup>

Within the model of Anderson and Kim,<sup>26</sup> E can be expressed in the thermally activated flux motion regime in a general form<sup>27</sup> as

$$E(J,T) = 2\rho_0 J_c \exp\left(\frac{-U}{k_B T}\right) \sinh\left(\frac{JU}{J_c k_B T}\right), \qquad (1)$$

where  $J_c$  is the critical current density at T=0, U(B,T)is the activation energy for flux jumps, and  $\rho_0(B,T)$  is the resistivity at  $J = J_c$ . Two limiting behaviors, which can be solved exactly for some geometries, can be distinguished. The thermally activated flux-flow (TAFF) regime is observed at low driving currents,  $J \ll J_c k_B T/U$ , where the sinh term may be replaced by its argument.<sup>28</sup> The resistivity is then given by

$$\rho_{\text{TAFF}} = \frac{E}{J} = \frac{2\rho_0 U}{k_B T} \exp\left[\frac{-U}{k_b T}\right] \,. \tag{2}$$

Note that there is no J dependence so that this describes a regime with Ohmic behavior. When  $U/k_BT >> 1$  and J is very close to  $J_c$ , backwards hopping of the vortices may be neglected, and the sinh term may be replaced by an exponential. The resistivity may then be expressed as

$$\rho = \frac{E}{J} = \rho_0 \frac{J_c}{J} \exp\left[\frac{U}{k_B T} \left[\frac{J}{J_c} - 1\right]\right] . \tag{3}$$

This is known as the flux-creep regime. This flux-creep resistivity describes a non-Ohmic regime, since it has a Jdependence. Equation (3) predicts exponential behavior at large current densities. However, as seen in Fig. 1 and observed previously, this region experimentally shows power-law behavior at large current densities. In fact, it has been reported that U depends on J as U(J) $= U_J \ln(J_0/J)$ , where  $J_0$  is the current density at which U approaches zero. When this is substituted into Eq. (1), it is found that  $\rho$  is dominated by power-law behavior, which frequently is observed.<sup>10,27</sup> Since flux creep is indicative of vortex pinning, this suggests that vortex pinning exists in the region between  $T_{Ohm}$  and  $T_g$ . The linearity of the low-J part of the E-J isotherms in this region is indicative of an exponential creep rate, but the actual relaxation behavior is probably much more complicated than this,<sup>28</sup> and it may be too large to measure accurately.

For a superconductor containing sufficient disorder, recent vortex-glass-transition models describe a continuous phase transition from a vortex-liquid state above  $T_{g}$  into a vortex-glass state.<sup>4,5</sup> As in Fig. 1, these models predict that below  $T_g$  the *E-J* behavior will have a negative curvature that results from the divergence of the pinning potential U in the small-current-density limit. In this regime, the activation energy for a volume of the vortex lattice to jump diverges as  $1/J^m$ , for  $0 < m \le 1.^4$  Because of this divergence, the vortices become rigidly pinned, and the linear resistivity vanishes. The vortex-glass model of Fisher describes the J dependence of E at temperatures  $T < T_g$  as

$$E \propto \exp\left[-\left(\frac{J_c}{J}\right)^m\right],\tag{4}$$

where m is a universal exponent.<sup>4</sup> This equation shows negative curvature in a log-log plot. Since the linear resistance goes to zero, it is possible for supercurrents to persist indefinitely. Now, however, rather than having a logarithmic time dependence, which follows from the Anderson-Kim E-J form [Eq. (3)], the creep behavior is predicted to be nonlogarithmic in time.<sup>4</sup> This nonlogarithmic creep behavior has been observed in both crystals<sup>12</sup> and films<sup>29</sup> of YBCO.

The vortex-glass-transition model predicts that the data above and below  $T_g$  can be scaled onto separate universal curves.<sup>4</sup> The following scaling relations were used to determine  $T_{g}$ :

$$V/I \sim |T - T_g|^{\nu(z-1)}$$
 and  $I \sim |T - T_g|^{2\nu}$ . (5)

For a three-dimensional transition, it is expected that z > 4 and 1 < v < 2.<sup>15</sup> Figure 3 is typical of our scaled data, but note that the axes have been expressed in terms of  $\rho$  and J, which differ from Eq. (3) by constants and thus have no effect on the scaled parameters. The E-J data scale for the values z and v that are listed in Table I. There is a margin of error  $(\pm 1 \text{ K})$  in the determination of  $T_g$  resulting from the difficulty in determining the isotherm where the curvature changes from positive to negative. As observed previously in thin films,<sup>15</sup> these  $\vec{E-J}$ curves scale over a wide temperature range, which broadens with increasing field. Shown in Fig. 3 are the 10-kOe E-J data, which scale for up to about 5 K above  $T_{g}$ . The region over which scaling is observed is represented by the hatched area in Fig. 2. It is found that E-J data taken at 50 kOe scale up to about 8 K above  $T_g$ .

H (kOe) 30

50

40

20

10

0

70

ohm

Γ<sub>c2</sub> est.

75





FIG. 3. *E-J* curves at 10 kOe scaled to  $V/I \sim |T - T_g|^{\nu(z-1)}$ and  $I \sim |T - T_g|^{2\nu}$ . The temperatures of the curves scaled ranged from 87 to 75 K and a value  $T_g = 82.8$  K was determined.

All of the curves in the E-J data for  $T < T_g$  scale reasonably well. The dashed line in Fig. 1 is a plot of  $E(J, T = T_g)$  using the parameters z and  $T_g$  determined at 30 kOe. For a three-dimensional glass transition, the E-J curve at  $T_g$  may be expressed as  $E(J, T = T_g) = KJ^{(z+1)/2}$ , where z is a constant determined from scaling.<sup>4</sup> The values of  $T_g$  determined at various applied fields by scaling are those plotted in Fig. 2.

Although the E-J curves allow for the most accurate determination of the IRL, other methods that are much simpler to perform, such as dc magnetization and ac susceptibility, have been used for this purpose. Measuring E-J behavior is not only time consuming, but also complicated by the need to make low-resistance Ohmic contacts. In spite of these shortcomings, E-J measurements provide detailed information on the electromagnetic behavior of the superconductor.

# B. dc magnetization

The results of dc magnetization measurements on the 3000-Å-thick film are shown in Fig. 4. The curves in Fig. 4 correspond to three different types of measurements: (1) zero-field cooled (ZFC), (2) field cooled with data collected on warming (FCW), and (3) field cooled with data collected on cooling (FCC). For both the ZFC and FCW curves, there is a distinctive negative change in the apparent magnetization at a point we will denote  $T_{\rm dc}$ . The large values of this magnetization and the anomalous superconducting quantum interference device (SQUID) out-

TABLE I. Parameters v, z, and  $T_g$  at various magnetic fields as determined by scaling of the *E-J* data to  $V/I \sim |T - T_g|^{v(z-1)}$ and  $I \sim |T - T|^{2v}$ 

H (kOe)	Z	v	<i>T<sub>g</sub></i> (K)
10	6.7	1.5	82.8
30	6.8	1.6	77.8
50	6.8	1.7	74.0



FIG. 4. Typical dc magnetization curves for zero-field-cooled (ZFC), field-cooled with data collected on warming (FCW), and field-cooled with data collected on cooling (FCC) methods. At  $T_{vc}$  and above, the ZFC and FCW curves are coincident, while only at  $T_{dc}$  does the FCC curve become coincident with the other two. The sample is the same 3000-Å thin film of YBCO measured at H = 10 kOe. SSC identifies an experimental artifact described in the text.

put signals below this point are consistent with the disappearance of irreversibility at  $T_{\rm dc}$ .<sup>30</sup> As shown in Fig. 4 at H = 10 kOe, the ZFC and FCW curves are coincident from  $T_{\rm dc}$  down to  $T_{vc}$  where they split into two separate curves. On the other hand, as the temperature is decreased from above  $T_{\rm dc}$ , the FCC curve initially makes a negative deviation at  $T_{\rm dc}$  before turning positive. The FCC curve does not coincide with the FCW and ZFC curves except at  $T_{\rm dc}$  and above. The model of Clem and Hao predicts this general behavior.<sup>31</sup>

There are several technical considerations that complicate the use of dc magnetometer measurements. First, dc magnetometers are designed to measure samples with homogeneous magnetization, which is not always true of superconducting samples with strong pinning. The result of this inhomogeneous magnetization is that the signal observed is not of the point-dipole form that the instrument was designed to analyze. In these cases the quantitative accuracy (and even the sign) of the measurement must be questioned. However, these results can have value if used to observe relative changes. The point labeled SSC in Fig. 4 is an artifact related to the inability of the signal analysis procedure to properly fit the SQUID output. Steps like the one at SSC occur when the SQUID amplifier range is changed during measurement. Another unrelated technical consideration is associated with the motion of the sample during measurement. Because the sample is moved (cycled) during measurement, it is possible to cycle the sample through minor hysteresis loops unless the motion (scan length) is limited to a region of the applied magnetic field that is spatially homogeneous. This effect becomes more pronounced as the field is increased. The value of  $T_{dc}$  will be scan-length dependent at higher applied fields unless a sufficiently short scan length is used. The same value for  $T_{\rm dc}$  was determined for scan lengths of 3.0 cm and shorter. A determination of the IRL using the ZFC-FCC method with scan length

The FCW method, in which one determines the temperature where the FCW and ZFC magnetization curves split, does not in general permit an accurate determination of the irreversibility line. To show why this is so, it is of interest to make a detailed comparison of the fluxdensity profiles for three distinct cases: FCC (field-cooled magnetization, with data collected as the sample is gradually cooled in an applied magnetic field), FCW (fieldcooled magnetization, with data collected as the sample is gradually warmed in an applied magnetic field), and ZFC (zero-field-cooled magnetization, with data collected as the sample is gradually warmed in an applied magnetic field). The differences may be most clearly understood by considering the behavior of a long superconducting cylinder (radius R) in a parallel magnetic field  $H_0$ , using standard critical-state theory to account for the flux density (B) and temperature dependence of  $J_c(B,T)$  and  $B_{eq}(H_0, T)$  [or  $M_{eq}(H_0, T)$ ].

During a FCC magnetization measurement, the flux density at the surface drops, as it attempts to remain in equilibrium with the externally applied field. This leads to gradual flux expulsion. At each temperature point, the sample has a flux-density profile in which, as a function of distance  $\rho$  from the center, the local flux density  $B(\rho)$ decreases monotonically out to the surface. To illustrate this with a simple example, let us assume that the critical-state profiles of  $B(\rho, T)$  versus  $\rho$  can be calculated from  $dB/d\rho = \pm (4\pi/c)J_c(T)$ , where  $J_c$  is independent of B, but is a monotonically decreasing function of T. (We assume relatively weak pinning, such that the fluxtrapping depth<sup>32</sup> is always larger than R.) The temperature  $T_{dc}$  is the temperature above which  $J_c(T)$  is effectively zero. We define  $T_{c1}(H_0)$  and  $T_{c2}(H_0)$  as the temperatures T at which  $H_{c1}(T) = H_0$  and  $H_{c2}(T) = H_0$ , respectively. Shown in Fig. 5 are the resulting fluxdensity profiles  $B(\rho, T)$  for successively decreasing temperatures during field cooling:  $T \ge T_{cz}$  (curve a),  $T_{dc} \le T \le T_{c2}$  (curve b),  $T_{c1} < T < T_{dc}$  (curves c and d),



FIG. 5. Sketch of the FCC flux-density profiles  $B(\rho, T)$  vs distance  $\rho$  from the center of the cylinder, for decreasing temperatures during field cooling:  $T \ge T_{c2}$  (curve *a*),  $T_{dc} \le T < T_{c2}$ , (curve *b*),  $T_{c1} < T < T_{dc}$  (curves *c* and *d*), and  $T \le T_{c1}$  (curve *e*).

and  $T \leq T_{c1}$  (curve e). At each temperature the value of  $B(R,T) = B_{eq}(H_0,T)$ , and the slope of the  $B \cdot \rho$  curve is  $-(4\pi/c)J_c(T)$ . At temperatures  $T_{dc} \leq T < T_{c2}$ , this slope is zero, but as T drops below  $T_{dc}$  the critical-state slope becomes steeper. Note that  $B(R,T_{c2}) = H_0$  (Fig. 5, curve a) because  $H_0 = H_{c2}$  when  $T = T_{c2}$  and that  $B(R,T_{c1}) = 0$  (Fig. 5, curve f) because  $H_0 = H_{c1}$  at  $T = T_{c1}$ .

Shown in Fig. 6 are flux-density profiles  $B(\rho, T)$ , sketched for successively increasing temperatures during a FCW magnetization measurement:  $T \leq T_{c1}$  (curve a),  $T_{c1} < T < T_{vc}$  (curves b and c),  $T = T_{vc}$  (curve d),  $T_{vc} < T < T_{dc}$  (curve e),  $T_{dc} \le T < T_{c2}$  (curve f), and  $T > T_{c2}$  (curve g). During a FCW measurement, only at the lowest temperatures  $T \leq T_{c1}$  [compare Figs. 6 (curve a) and 5 (curve e)] does the flux-density profile decrease monotonically out to the surface. As the temperature increases above  $T_{c1}$  (Fig. 6, curves b and c) the flux density at the surface increases, and a flux-density front (having a higher flux density at the surface than at some point farther in) advances inward. The flux-density profile  $B(\rho)$ has a V-shaped minimum at some radial coordinate  $\rho_{u}$ , where  $0 < \rho_v < R$ . The slope  $dB/d\rho = (4\pi/c)J_c(T)$  for  $\rho > \rho_v$ , where magnetic flux is moving inward, and  $dB/d\rho = -(4\pi/c)J_c(T)$  for  $\rho < \rho_v$ , where flux is moving outward. At temperature  $T_{vc}$  (Fig. 6, curve d), the Vshaped minimum in  $B(\rho)$  just touches the center of the sample ( $\rho_v = 0$ ). For temperatures  $T_{vc} < T < T_{dc}$  (Fig. 6, curve e), the local flux density increases monotonically out to the surface, and flux continuously enters the sample as the temperature rises. The slope of the flux-density profile decreases and eventually becomes perfectly flat at  $T_{\rm dc}$  (Fig. 6, curve f). At temperatures  $T \ge T_{c2}$  (Fig. 6, curve g), bulk superconductivity is quenched, and  $B(\rho) = H_0.$ 

Shown in Fig. 7 are flux-density profiles  $B(\rho, T)$ , sketched for successively increasing temperatures during a ZFC magnetization measurement:  $T \leq T_{c1}$  (curve *a*),  $T_{c1} < T < T_{dc}$  (curves b-e),  $T_{dc} \leq T < T_{c2}$  (curve *f*), and  $T \geq T_{c2}$  (curve *g*). Initially,  $B(\rho, T)=0$  for all temperatures below  $T_{c1}$  (Fig. 7, curve *a*). As the temperature rises above  $T_{c1}$ , however, a flux-density front [having a



FIG. 6. Sketch of the FCW flux-density profiles  $B(\rho, T)$  vs distance  $\rho$  from the center of the cylinder, sketched for increasing temperatures:  $T \leq T_{c1}$  (curve a),  $T_{c1} < T < T_{vc}$  (curves b and c),  $T = T_{vc}$  (curve d),  $T_{vc} < T < T_{dc}$  (curve e),  $T_{dc} \leq T < T_{c2}$  (curve f), and  $T \geq T_{c2}$  (curve g).



FIG. 7. Sketch of the ZFC flux-density profiles  $B(\rho, T)$  vs distance  $\rho$  from the center of the cylinder, sketched for increasing temperatures:  $T \leq T_{c1}$  (curve a),  $T_{c1} < T < T_{dc}$  (curves b-e),  $T_{dc} \leq T < T_{c2}$  (curve f), and  $T \geq T_{c2}$  (curve g).

higher flux density at the surface than at some point farther in, with slope  $dB/d\rho = (4\pi/c)J_c(T)$ ] appears at the surface (Fig. 7, curve b), and its advances inward as the temperature gradually increases. At some temperature (Fig. 7, curve c) this flux-density front reaches the center of the sample. As the temperature further increases, the slope of the flux-density profile decreases (Fig. 7, curves dand e), eventually becoming perfectly flat at  $T_{dc}$  (Fig. 7, curve f). Note that the flux-density profiles for FCW and ZFC are identical for temperatures  $T \ge T_{vc}$  (curves d, e, and f in Figs. 6 and 7). Thus the magnetization curves for the two processes must be identical for  $T \ge T_{vc}$ . It is clear, however, that  $T_{vc}$  has nothing to do with the irreversibility temperature, since the joining of the magnetization curves at  $T_{vc}$  follows from the critical-state model, which is describing the irreversibility of the sample.

Shown in Fig. 8 is a sketch of the resulting FCC, FCW, and ZFC magnetization curves. Because the flux-density profiles are frozen in at temperatures below  $T_{c1}$ , the magnetization versus temperature is flat in this temperature range. In the temperature range  $T_{c1} < T < T_{dc}$ , where the critical-current density obeys  $J_c > 0$ , the critical-state



FIG. 8. Sketch of the FCC, FCW, and ZFC magnetizations vs temperature T. The FCC and ZFC magnetization curves separate below  $T_{dc}$  [Figs. 5 (curve b) and 7 (curve f)], which we identify as the vortex-glass transition temperature. The FCW and ZFC magnetization curves, however, separate below  $T_{vc}$  (Fig. 6, curve d), an effect that has nothing to do with the irreversibility temperature, since it occurs even when  $J_c$  is large.

model requires that the FCC magnetization curve (which describes a flux density that everywhere has *negative* slope, as in Fig. 5) must lie above the FCW magnetization curve (which describes a flux density that has positive slope near the surface, as in Fig. 6). Only when  $(4\pi/c)J_c(T)R$  is immeasurably small by comparison with  $H_0$ , i.e., only when  $T \ge T_{dc}$ , is the flux-density profile for all practical purposes flat. For such temperatures, the flux-density profiles for FCC, FCW, and ZFC all agree, and one is then measuring simply the reversible (equilibrium) magnetization curve. The FCW and ZFC curves separate only at temperatures below  $T_{vc}$ , while the FCC and ZFC curves separate only at temperatures below  $T_{dc}$ , which we identify as the vortex-glass transition temperature  $T_g$ .

An examination of Fig. 4 shows that, as predicted, the ZFC and FCW curves are superimposed to temperatures well below  $T_{\rm dc}$ , while the FCC curve is only coincident with the ZFC curve above  $T_{\rm dc}$ . Without further measurement, it is not possible to confirm that  $T_{\rm dc}$  is an approximate determination of  $T_g$ . However, it would seem very likely to be so. At some point the magnetic moment associated with the irreversible magnetization falls below the resolution of the magnetometer, which will lead to an underestimate of the temperature where  $J_c$  disappears. Therefore a determination of the vortex-glass transition by dc magnetization measurements is expected to fall at a temperature lower than that determined by transport measurements.

#### C. Fundamental-frequency ac susceptibility

Shown in Fig. 9 is a plot of  $V'_1$  and  $V''_1$ , which are proportional to  $\chi'_1$  and  $\chi''_1$ , the in- and out-of-phase components of the fundamental-frequency (or first-harmonic) ac susceptibility, as a function of temperature for a



FIG. 9. Temperature dependence of voltages  $V'_1$  and  $V''_1$ , which are proportional to the in-phase  $(\chi')$  and out-of-phase  $(\chi'')$  components of the fundamental-frequency as susceptibility. Also shown is the voltage  $|V_3|$ , which is proportional to the magnitude of the third-harmonic as susceptibility  $|\chi_3|$ , as a function of temperature for the same 3000-Å thin film of YBCO. The fundamental frequency is 70 000 Hz, and as amplitude  $H_0 = 8$  Oe, and the applied dc field H = 10 kOe. The onset of the first and third harmonics occurs at the same temperature, which indicated by the arrows.

YBCO thin film.  $\chi'_1$  and  $\chi''_1$  can be physically interpreted as measures of ac magnetic field screening and loss, respectively. This can be seen by considering a cylinder of radius R, composed of a conducting material that has been subjected to an oscillating magnetic field superimposed on a constant magnetic field parallel to the axis of the cylinder,  $H = H_{dc} + h_0 \cos(2\pi f t)$ .<sup>17</sup> The timedependent volume-averaged magnetic induction in the cylinder may be written

$$\boldsymbol{B} = \boldsymbol{B}_{\rm dc} + \boldsymbol{b}\left(t\right),\tag{6}$$

where

$$b(t) = h_0 \cos(2\pi f t) + 4\pi m(t) .$$
(7)

Since m(t) is periodic in time with period 1/f, it can be Fourier expanded in terms of frequency f and a complex harmonic susceptibility  $\chi_n = \chi'_n + i\chi''_n$  as follows:

$$m(t) = h_0 \sum_{n=1}^{\infty} \left[ \chi'_n \cos(2\pi n f t) + \chi''_n \sin(2\pi n f t) \right].$$
 (8)

When the background signal is properly nulled, the measured voltage of an N-turn pickup coil wrapped around the cylinder is then

$$V(t) = \frac{-N\pi R^2}{c} 4\pi \frac{dm(t)}{dt}$$
  
=  $-4\pi h_0 \frac{N\pi R^2}{c} \sum_{n=1}^{\infty} 2\pi fn \{\chi_n'' \cos(2\pi fnt) -\chi_n' \sin(2\pi fnt)\}$ . (9)

A lock-in amplifier is typically used to separate these harmonic voltages, which are directly proportional to the harmonic susceptibilities. When the first harmonic is detected, the volume-averaged ac magnetic induction in the cylinder may be expressed in terms of  $\chi'_1$  and  $\chi''_1$  as

$$b_1(t) = h_0 \cos(2\pi f t) + 4\pi m_1(t)$$
  
= Re{[1+4\pi(\chi\_1'+i\chi\_1'')]h\_0 e^{-i2\pi f t}}

This equation can be used to demonstrate that  $\chi'_1$  is a measure of screening. When the cylinder is completely unscreened,  $b_1(t) = h_0 \cos(2\pi f t)$ . For this to be true,  $\chi'_1 = \chi''_1 = 0$ . In this case, the ac magnetic induction in the cylinder is large, but the induced screening current density J is small. Therefore losses are small. When the cylinder is completely screened, the ac magnetic field penetration depth  $\delta = (c/2\pi)(\rho/f\mu)^{1/2}$ , where  $\mu$  is the permeability and  $\rho$  is the resistivity, is small. In this case,  $b_1(t)=0$ , so that  $\chi'_1=-1/4\pi$  and  $\chi''_1=0$ . Losses will also be small in this case since the ac magnetic induction in the cylinder is small. Thus  $\chi'_1$  is a measure of screening, and the more negative the value of  $\chi'_1$ , the greater the amount of screening. The onset temperature of ac magnetic screening ( $T_{on}$ ) is shown in Fig. 9.

In the regime of incomplete screening, both J and the ac magnetic induction in the cylinder can become large, so that ac losses will be large. The energy loss per unit volume per cycle can be computed from  $(1/4\pi) \int H dB$ . When Eqs. (6) and (8) are used for B in this integral, the

energy loss per unit volume per cycle is found to be  $\pi h_0^2 \chi_1''$ . It is important to note that the higher harmonics of m(t) do not contribute to this integral. Thus  $\chi_1''$  is a measure of loss. In general, losses are maximized when  $\delta$  is on the order of some geometry-dependent length.  $\chi_1''$  will have a peak at the lowest temperature,  $T_p$ , where the ac magnetic induction has fully penetrated the sample. For the case of a long cylinder and an ac field applied parallel to its axis, it has been found that losses are maximized when  $\delta = R/1.8$ .<sup>17</sup>  $T_p$  is dependent on sample size, geometry,  $\rho$ , and f.

For a film patterned into a circle with radius R and the magnetic field applied normal to its surface, we estimate that  $T_n$  will occur at a value of the resistivity

$$\rho_{\rm peak} \sim 2\pi^2 \mu f R d / c^2 , \qquad (10)$$

where d is the thickness of the film. This follows from setting the two-dimensional screening length  $\Lambda_f$  for an ac magnetic field perpendicular to the film's surface equal to  $R (\Lambda_f = 2\delta^2/d = R)$ . Thus  $T_p$  may be moved to different  $\rho$  values by varying f.

The above is true for normal metals.<sup>17</sup> For superconductors, however, both  $\rho$  and  $\chi$  are dependent on the magnetic field. Since the resistivity of a superconductor is due to flux motion,  $\rho$  should be replaced with the flux-flow resistivity  $\rho_f$  and  $\mu$  should be taken as the differential permeability in thermodynamic equilibrium.<sup>17</sup> The flux-flow skin depth is then represented as  $\delta_f = (c/2\pi)(\rho_f/f\mu)^{1/2}$ .

If pinning is present, then losses may be represented as  $JE = E^2/\rho_f + J_c E$ , where the first and second terms on the right-hand side represents losses due to flux flow and pinning, respectively.<sup>33</sup> When  $E \gg \rho_f J_c$ , the above equations for flux penetration apply. If  $E \ll \rho_f J_c$ , the peak in  $\chi_1''$  will still occur when the ac magnetic induction has penetrated to some geometry-dependent length, but the penetration depth  $L_p$  will have a frequency dependence that is small in comparison with its  $h_0$  dependence. In this case,  $L_p$  will be proportional to  $h_0$ . For the specific case of a cylinder,<sup>17</sup>  $L_p$  is given by the condition

$$L_P = \frac{h_0 c}{4\pi J_c} \ . \tag{11}$$

This crossover in the penetration depth to  $L_p$  occurs at low frequencies. This is because at low frequencies the  $\rho$ value required for the skin depth to be on the order of R[see Eq. (10)] occurs at a temperature below  $T_g$ , where pinning is strong.

In spite of the fact that  $T_p$  is actually a function of sample size and geometry, the measuring frequency, and the sample resistivity, it has been used by some to determine the IRL. The  $\chi_1''$  peak is not a direct measure of the onset of irreversible magnetic behavior. The fundamental frequency  $\chi_{ac}$  response measures the extent to which an ac field has penetrated into the sample. At low f,  $T_p$  is more strongly dependent on  $h_0$ , and at high f,  $T_p$  is more strongly dependent on f. At intermediate f, the  $T_p$ dependence on  $h_0$  and f is not well defined, and may be a complicated function of both  $h_0$  and f.<sup>17</sup>

A schematic presentation of the dependencies of the  $\chi_1''$ peak is shown in Fig. 10.<sup>34</sup> When measuring the  $\chi_{ac}$ response of a superconductor at high f, the position of the  $\chi_1''$  peak shifts to higher temperature as the measuring frequency is increased. In this case the peak  $(T_p)$  will occur at a temperature above the actual onset of irreversibility,  $T_g$ . This is the region to the right of  $T_g$  in Fig. 10. From Eq. (10), it can be seen that as f is increased,  $\rho_{\text{peak}}$  will increase; thus  $T_p$  must also increase. For sufficiently small values of  $\rho_{\text{peak}}$ , however, the penetration depth crosses to  $L_p$  as described above. This is the region shown to the left of  $T_g$  in Fig. 10. When this happens,  $T_p$ is less than  $T_g$ . The position of  $T_p$  in this regime will be dependent on  $L_p$  and thus on  $h_0$  and  $J_c$ , as in Eq. (11). From Eq. (11) it can also be seen that if  $L_p$  is to remain on the order of R,  $J_c$  must increase as  $h_0$  increases. Therefore, for small values of f,  $T_p$  shifts to lower temperature with increasing  $h_0$ .

It follows that  $T_p$  occurs at temperatures greater than  $T_g$  at high frequencies and at temperatures less than  $T_g$  at low frequencies. The dependence of the  $\chi''_1$  peak on f at higher frequencies and  $h_0$  at lower frequencies makes it impossible to accurately determine  $T_g$  with a single temperature sweep at a single value of f and  $h_0$ . In order to approximate  $T_g$  using this method, it is necessary to take several temperature sweeps at constant H, while varying either f or  $h_0$ . In either case, it should be possible to determine  $T_g$  approximately by extrapolation. As will be discussed below, measuring  $T_{on}$  offers an alternative method for measuring  $T_g$ .

### D. Third-harmonic ac susceptibility

The higher order harmonics of  $\chi_{ac}$  have been used as a measure of the onset of irreversible magnetic behavior in various systems, including superconductors.<sup>16,35</sup> When the magnetic behavior of a material is completely reversible *and* the *E-J* relationship is linear, there will be no higher-order harmonics associated with  $\chi_{ac}$ . However, when the *E-J* relationship is nonlinear, there will be a



FIG. 10. Schematic presentation of the temperature at which the peak  $(T_p)$  in the out-of-phase component  $(\chi'')$  of the firstharmonic  $\chi_{ac}$  is observed. The lines correspond to the temperature dependence of the critical current density  $(J_c)$  and resistivity  $(\rho)$ . Because first-harmonic  $\chi_{ac}$  measures magnetic field penetration and not irreversibility, at higher frequencies  $T_p$  is dependent on frequency, while at lower frequencies  $T_p$  depends on amplitude (after A. M. Campbell).

nonlinear *M-H* response and the generation of higherorder harmonics, whether the system is reversible or irreversible. When the magnetic behavior is irreversible, it follows that the *E-J* relationship must be nonlinear. As was shown by Bean, the odd harmonics of the hysteretic response of a superconductor in the critical state are always present.<sup>20</sup> The even harmonics will also be present if the hysteresis loop is asymmetric with respect to the origin.<sup>35</sup>

Shown in Fig. 9 are the voltages  $V'_1$  and  $|V_3|$  proportional to both the in-phase part of the fundamental  $\chi_{ac}$ response,  $\chi'_1$ , and the magnitude of the third-harmonic  $\chi_{ac}$  response,  $|\chi_3| = |\chi'_3 + i\chi''_3|$ , respectively, as a function of temperature measured using a fundamental frequency  $f = 70\,000$  Hz in an applied dc field H = 10 kOe for the 3000-Å YBCO thin film. Clearly, as indicated in Fig. 9, both the fundamental and third-harmonic onsets are coincident. We have found a coincidence of the onsets of both the fundamental and third-harmonic  $\chi_{ac}$  responses at fundamental frequencies ranging from 0.7 to 70000 Hz. This is consistent with the observations of other groups.<sup>36</sup> The temperature of the onset  $(T_{on})$  of both  $\chi_{ac}$ responses, in various applied dc fields, is plotted in Fig. 2 showing that at  $f = 70\,000$  Hz this curve falls well above  $T_g(H)$ . Plotted in Fig. 11 is the frequency dependence of  $T_{on}$  for an applied dc field H = 50 kOe showing  $T_{on}$  increasing with f. The points are experimental data and the line is a fit of the form  $T_{on} = C(2\pi f)^{\{1/[(z-1)\nu]\}} + T_g$ , with z = 6.8 and v = 1.7 determined by scaling of the E-J data. The glass model of Fisher<sup>4</sup> predicts this dependence for  $T_p$ , rather than  $T_{on}$ , at low frequencies. How-ever, both  $T_p$  and  $T_{on}$  are measures of ac flux penetration, since both are determined by values of the ratio  $\delta_f/R$  (larger in the case of  $T_{\rm on}$ ),<sup>17</sup> and so a similar frequency dependence is expected for  $T_{on}$ . For f=0 Hz this fit extrapolates to  $T_{\rm on} = 73$  K, which is in agreement with the value of  $T_g = 74 \pm 1$  K determined from the E-J results.

The coincidence of the fundamental and third-



FIG. 11. Frequency dependence of the onset temperature  $(T_{\rm on})$  of the third-harmonic  $\chi_{\rm ac}$  response for the 3000-Å YBCO thin film. The points are experimental data and the line is a fit of the form  $T = C(2\pi f)^{\{1/[(z-1)\nu]\}} + T_g$ , using z = 6.8 and  $\nu = 1.7$  determined by scaling. The glass model (Ref. 4) predicts this dependence for ac flux penetration at low frequencies.

harmonic responses is not unexpected given that  $T_p$  and the  $\chi_1$  and  $\chi_3$  onsets all occur within a temperature regime (between  $T_g$  and  $T_{Ohm}$ ) in which the *E-J* behavior is nonlinear. This coincidence results from the occurrence of ac flux penetration in a region where the nonlinear *E-J* behavior leads to the generation of harmonics resulting from a nonlinear *M-H* response. At low enough  $h_0$  and low enough frequency, the *E-J* behavior is Ohmic, suggesting that the third harmonic could be eliminated. Some of our preliminary results suggest that this may be possible. Both the *E-J* behavior and the presence of a third-harmonic  $\chi_{ac}$  response are consistent with the existence of flux pinning in this region. However, because of the nonzero linear resistance, a critical state can exist only transiently above  $T_g$ .

Rather than measuring the onset of irreversibility, the results presented suggest that  $\chi_3$  measures the same phenomenon that  $\chi_1$  measures, i.e., ac flux penetration. At very low frequencies and sufficiently small amplitudes, the onsets of  $\chi_1$  and  $\chi_3$  should be very close to  $T_g$ . This is because  $T_{\rm on}$  is not likely to move below  $T_g$  due to the strong pinning at  $T_g$ , which eliminates the linear resistivity and results in the establishment of a nontransient critical state below  $T_g$ . This indicates that there is at least partial screening of ac magnetic fields at all frequencies below  $T_g$ . At sufficiently high frequencies,  $T_{\rm on}$  will occur above  $T_{\rm Ohm}$  where the *E-J* relationship is linear. In this case, harmonics should no longer be present.

# E. Summary

Based on the measurements presented here, there appears to be only one IRL in YBCO thin films, and it is the same as the transition at  $T_g$ . The transition at  $T_g$  is characterized by the loss of a low-current linear resistance and the resulting appearance of a  $J_c$  that persists to infinite time due to the divergence of U with decreasing J. It is still not clear whether or not the magnetic behavior above  $T_g$  and below  $T_{\rm Ohm}$  can actually be considered reversible, except in the small E-J limit, where the E-J

behavior is Ohmic. Between  $T_g$  and  $T_{Ohm}$ , the E-J behavior is characteristic of thermally activated flux motion, which suggests that flux pinning still influences flux dynamics in this temperature region. Because of the nonzero linear resistance, a critical state can exist only transiently above  $T_g$  and on a sufficiently long time scale the sample will show evidence of reversible behavior. The nature of the phase at temperatures above  $T_g$ remains an important unresolved problem.

It has also been our purpose to show that some of the discrepancies in measuring the IRL are a result of inappropriate interpretation of experimental methods. We have shown that because ac flux penetration occurs in a region in which the *E-J* behavior is nonlinear, there is a coincidence of the fundamental-frequency and third-harmonic  $\chi_{ac}$  response onsets. Therefore neither  $\chi_{ac}$  response is an accurate measure of  $T_g$ , except in the limit of low frequency and low  $h_0$ . We have also shown that to measure  $T_g$  using dc magnetization requires that the combination of ZFC and FCC methods be used. The commonly used combination of  $T_g$ .

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